

Prototype Printed Circuit Board for Readout of a Handheld Dual Particle Imager

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Figure 7: Oscilloscope measurement setup

Figure 8: Perfboard / breakout board

measurement setup

Figure 9: Prototype TB-1 Eagle

schematic

Consortium for Verification Technology (CVT)

Introduction

Abstract

A handheld dual particle imager (H²DPI) is being designed and built for nuclear nonproliferation and safeguards applications. The design has been made compact through the use of silicon photomultiplier (SiPM) arrays coupled to stilbene crystals. To meet the requirements of the H²DPI, the readout electronics for this imager must:

- Be durable
- Be compact
- Output pulses with precise timing and height proportional to deposited neutron energy

To that end, a custom printed circuit board (PCB) is being designed to read out signals from SiPM arrays for further data processing.

SiPM Array

- SensL ArrayC-60035-64P
- 64 SiPM pixels, which can be individually read out
- Each pixel is composed of 18,600 lightsensitive photodiodes
- Microcells sum together to produce a pulse at the anode of the pixel when struck with light
- Each measured pulse contains information about the position, time, and deposited energy of the interacting particle
- Proper readout from the sensor array is essential for accurate imaging

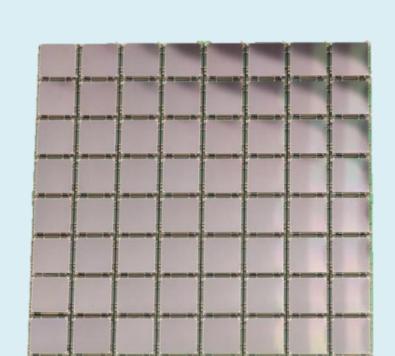


Figure 1: SensL ArrayC—64P SiPM Array

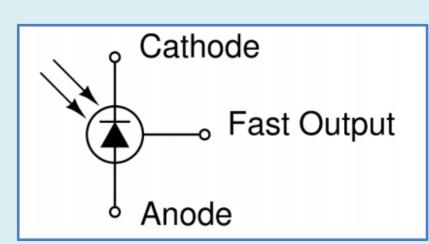


Figure 2: SensL SiPM component

8-Pixel SiPM Readout PCB

- Simultaneously reads out eight strategically placed pixels
- Preserves accuracy of signal shape and timing through impedance matching and trace length matching
- Accepts voltage bias from and reads out SiPM signals through independent SMA jacks

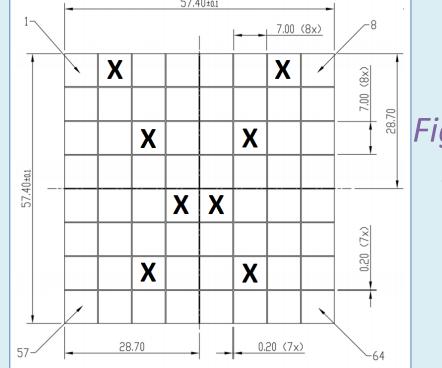


Figure 3: 8-pixel array layout

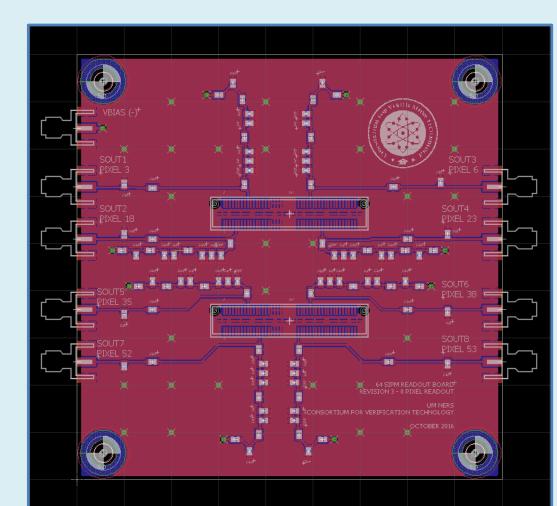


Figure 4: 8-Pixel SiPM Readout PCB in CadSoft Eagle

Design Process

Simulation

- LTSpice SiPM model produces simulated waveforms of a single pixel
- Observed effects of changing readout methods on signal:
 - Rise time
 - Peak height
 - Signal shape
- Facilitates optimizing readout circuit for accurate timing and pulse height response

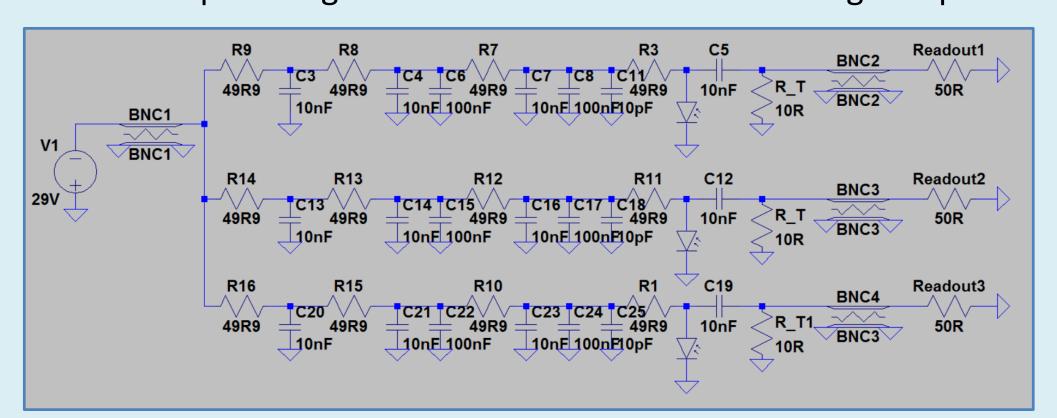
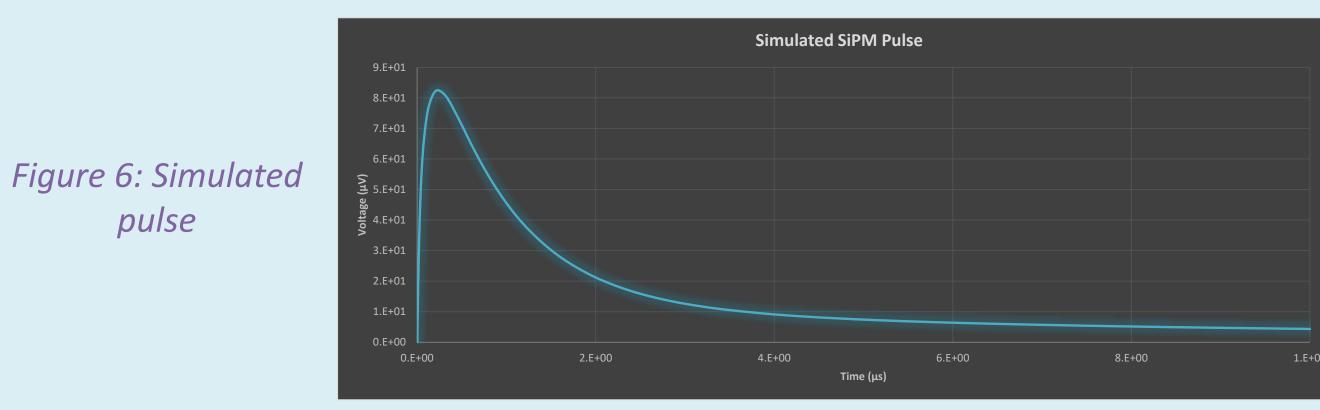


Figure 5: LTSpice simulated 3-pixel readout circuit



Prototyping

Stage 1 Experimental Setup:

- Perfboards
- Through-hole components
- SensL ArrayC-60035-64P Breakout Board
- Power supply
- Oscilloscope
- Dark box

Stage 1 Results:

- Observed similar pulse shape and height to simulation
- Small, but significant crosstalk product of lower quality construction

Stage 2 Experimental Setup:

- Printed circuit boards
- Surface mount (SMT) components
- SensL ArrayC-60035-64P SiPM Array
- Power supply
- Digitizer
- Dark box

bias filter

- Generated schematic and board files in Eagle
- Printed boards via external supplier
- Assembled board and components via reflow soldering
- Evaluated boards: TB-1, TB-2a, TB-2b

TB-2a Results: Resistors

- Largest noise of all stage 2 Least noise
- prototypes Strong timing resolution

TB-1 Results: Standard voltage

No observed crosstalk



Figure 10: Prototype TB-1

removed from bias filter

- Appreciable crosstalk observed
- Strong timing resolution

TB-2b Results: Standard filter, "timing resistor"

- Moderate noise
- Strongest timing resolution
- No observed crosstalk
- Small pulses

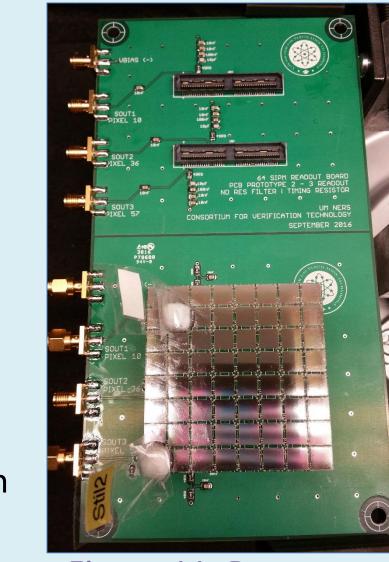


Figure 11: Prototypes TB-2a and TB-2b

Further Work

- Determine optimal readout circuit, taking findings from prototypes into consideration
- Apply this design to 8-pixel readout PCB
- Construct H²DPI to deliver maximum timing performance, energy resolution, and robustness

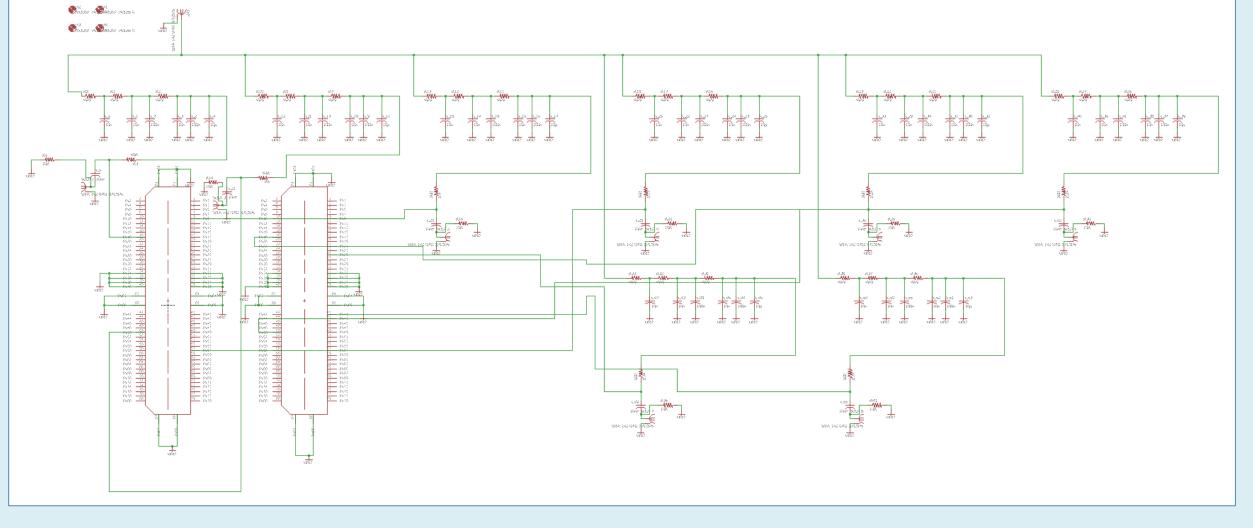


Figure 12: 8-pixel readout board preliminary schematic

Conclusions

- Prototype PCBs produce faithful readout signals for 3 pixels
- Several designs are being tested, with different timing and pulse height responses
- Expanding to 8 pixel readout is trivial once a design is selected

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